

Features

- $BV_{DSS}=650V$, $I_D=30A$
- $R_{DS(on)}:0.13\Omega$ (Max) @ $V_{GS}=10V$
- Very Low FOM ($R_{DS(on)} \times Q_g$)
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode

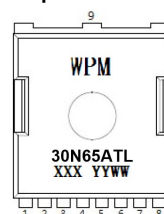
Application

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC to DC Converters
- Telecom, Solar

Pin Description

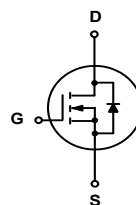
Pin	Description
1	Gate(G)
2,3,4,5,6,7,8	Source(S)
9	Drain(D)

Simplified Outline



Top View
TOLL

Symbol



Device Marking and Package Information

Ordering code	Package	Marking
WTM30N65ATL	TOLL-8L	30N65ATL XXX YYWW

Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise specified

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	650	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous ($T_C = 25^\circ C$)	30 *	A
	Drain Current - Continuous ($T_C = 100^\circ C$)	15.8 *	A
$I_{DM}^{1)}$	Drain Current - Pulsed	80 *	A
$E_{AS}^{2)}$	Single Pulsed Avalanche Energy	454	mJ
I_{AR}	Avalanche Current	3.1	A
dv/dt	MOSFET dv/dt ruggedness, $V_{DS}=0 \dots 400V$	50	V/ns
dv/dt	Reverse diode dv/dt, $V_{DS}=0 \dots 400V$, $I_{DS} \leq I_D$	15	V/ns
P_D	Power Dissipation ($T_C = 25^\circ C$)	34	W
$V_{ESD(G-S)}$	Gate source ESD(HBM-C=100pF, R=1.5K Ω)	2000	V
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ C$

* Drain current limited by maximum junction temperature

Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	3.65	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	80	$^\circ C/W$

Electrical Characteristics $T_J=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
On Characteristics						
V _{GS}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 1.1 mA	2.0	-	4.0	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 10.2 A	-	115	130	mΩ
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1mA	650	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650 V, V _{GS} = 0	-	-	1	μA
		V _{DS} = 650 V, T _C = 150°C	-	-	100	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	-	-	±1	μA
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 400 V, V _{GS} = 0 V, f = 1.0 MHz	-	2840	-	pF
C _{oss}	Output Capacitance		-	61	-	pF
C _{rss}	Reverse Transfer Capacitance		-	3.8	-	pF
Switching Characteristics						
t _{d(on)}	Turn-On Time	V _{DS} = 325 V, I _D = 14.3 A, R _G = 25 Ω (Note 3,4)	-	56	-	ns
t _r	Turn-On Rise Time		-	31	-	ns
t _{d(off)}	Turn-Off Delay Time		-	250	-	ns
t _f	Turn-Off Fall Time		-	20	-	ns
Q _{g(}	Total Gate Charge	V _{DS} = 520 V, I _D = 14.3 A, V _{GS} = 10 V (Note 3,4)	-	65	-	nC
Q _{gs}	Gate-Source Charge		-	12	-	nC
Q _{gd}	Gate-Drain Charge		-	19	-	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	30	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	80	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 14.3 A	-	-	1.3	V
trr	Reverse Recovery Time	V _R = 400 V, I _F = 14.3 A di _F /dt = 100 A/μs	-	450	-	ns
Qrr	Reverse Recovery Charge		-	7.8	-	μC

Notes :

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $I_{AS}=3.1\text{ A}$ $V_{DD}=100\text{ V}$, $R_G=25\text{ }\Omega$, Starting $T_J=25^\circ\text{C}$
3. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
4. Essentially Independent of Operating Temperature

Typical Characteristics

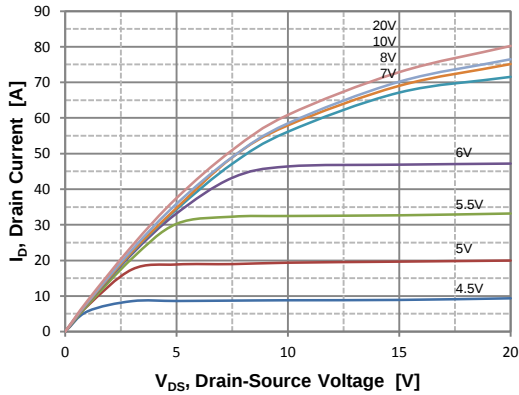


Figure 1. On Region Characteristics

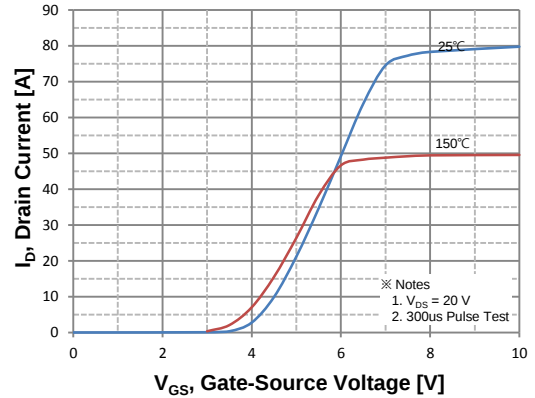


Figure 2. Transfer Characteristics

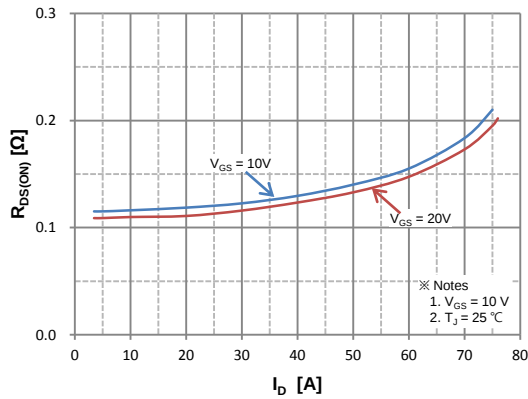


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

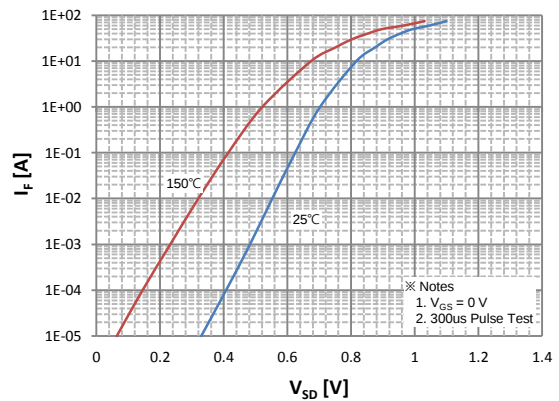


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

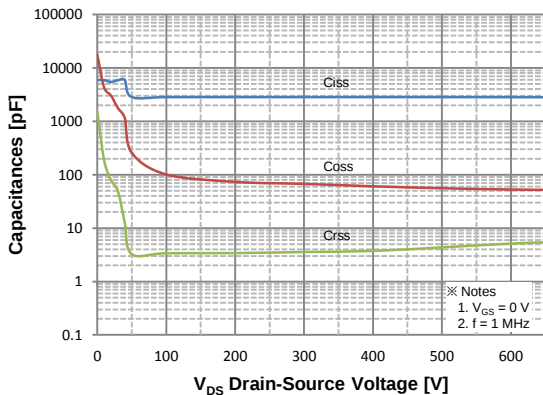


Figure 5. Capacitance Characteristics

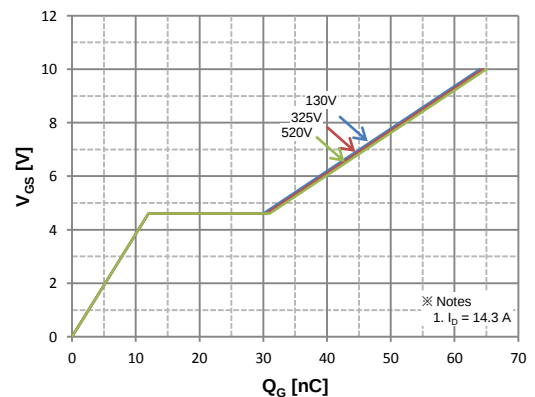


Figure 6. Gate Charge Characteristics

Typical Characteristics

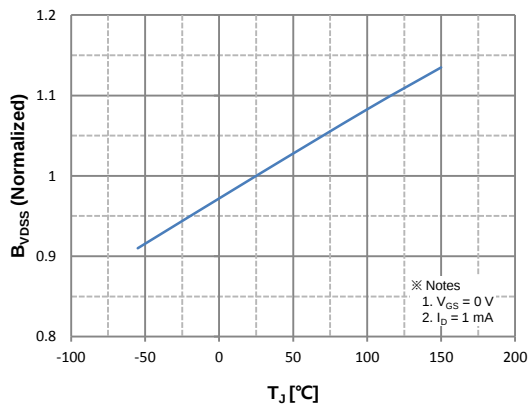


Figure 7. Breakdown Voltage Variation vs. Temperature

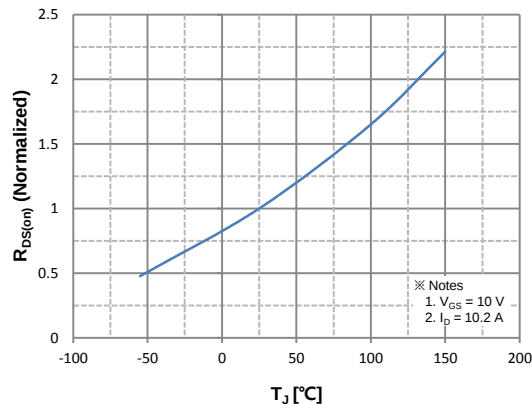


Figure 8. On-Resistance Variation vs. Temperature

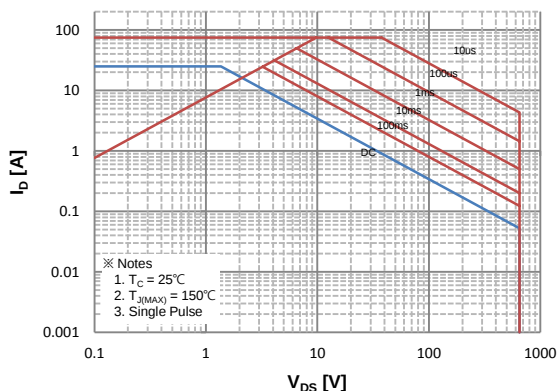


Figure 9. Maximum Safe Operating Area

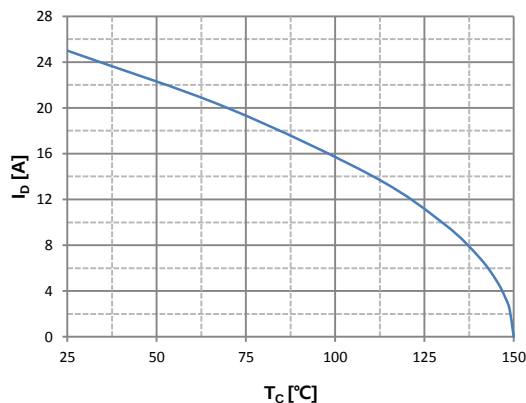


Figure 10. Maximum Drain Current vs. Case Temperature

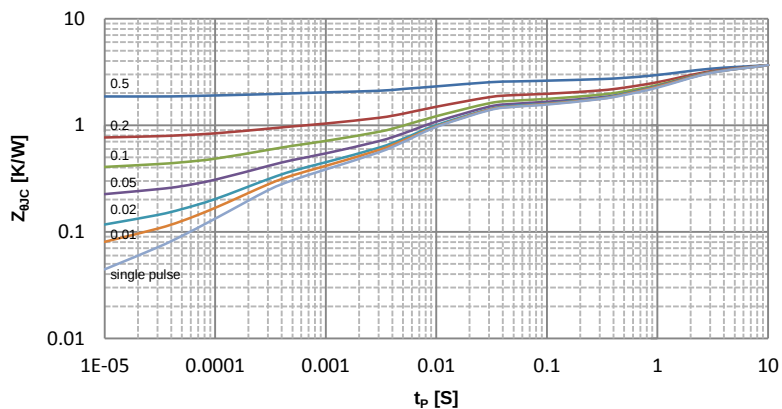


Figure 11. Transient Thermal Response Curve

Fig 12. Gate Charge Test Circuit & Waveform

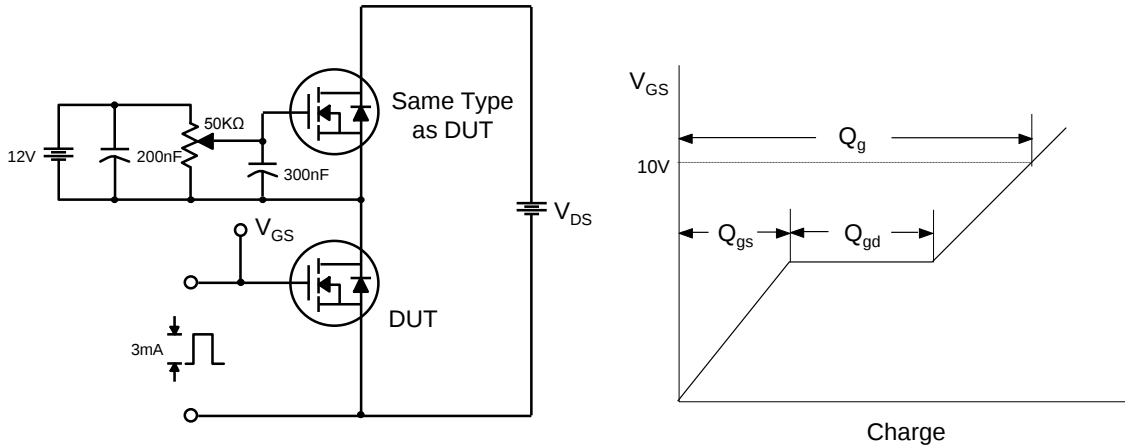


Fig 13. Resistive Switching Test Circuit & Waveforms

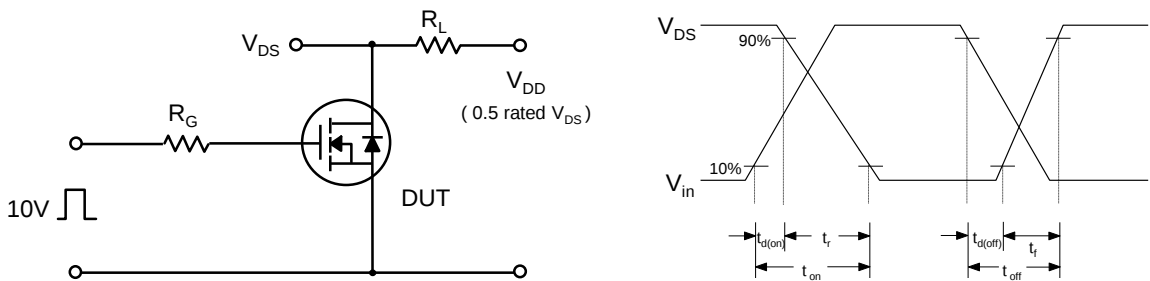


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

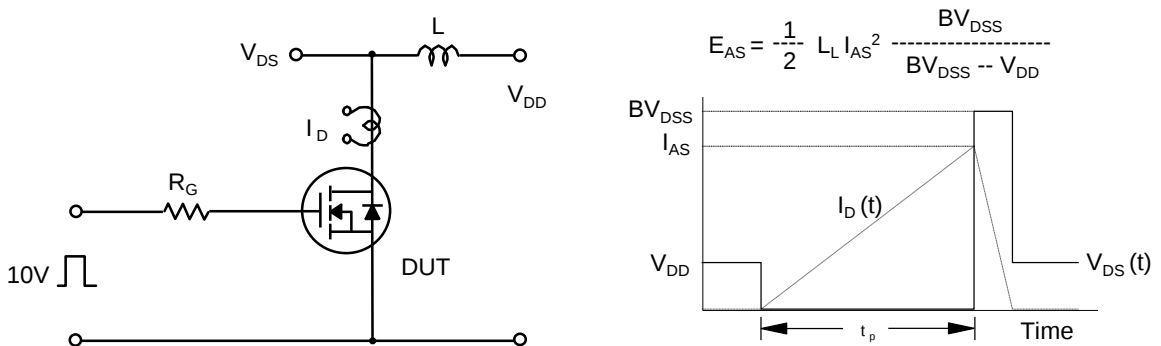
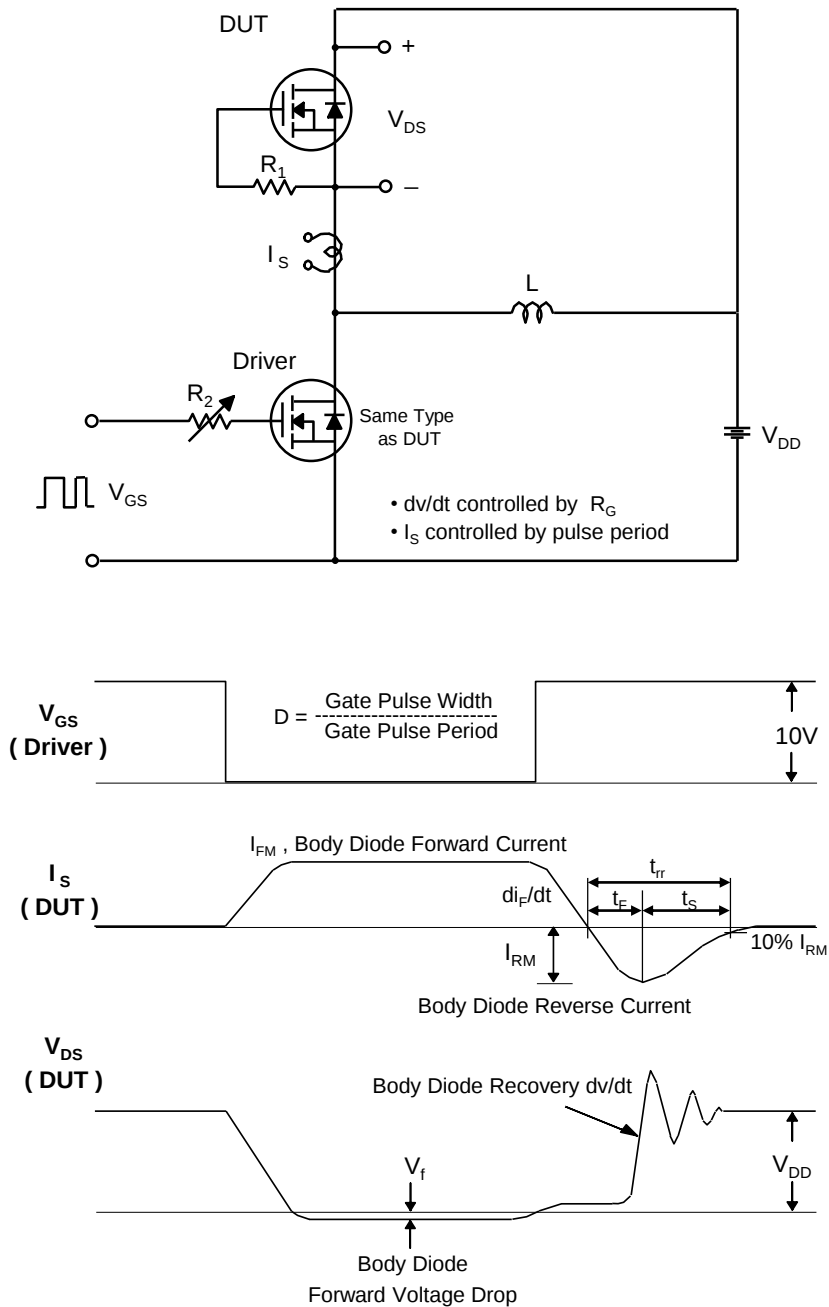
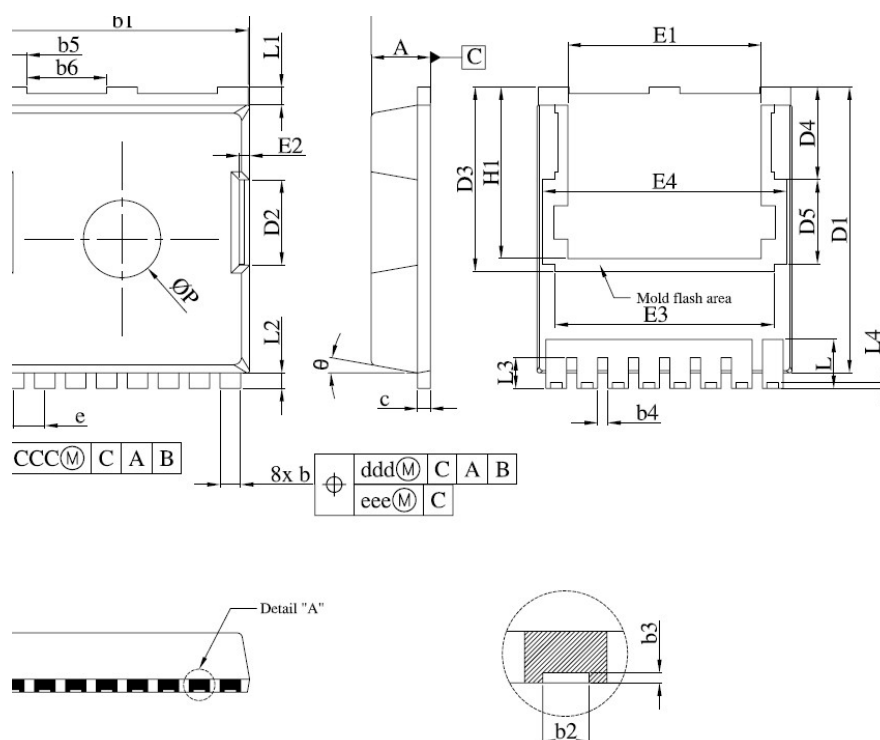


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



8. Package Dimensions TOLL-8L Package



Symbol	Dimensions In Millimeters	
	MIN.	MAX.
b	0.70	0.90
b3	0.05	/
b6	3.00	3.20
D1	10.98	11.18
D4	3.59	
E	9.80	10.00

Symbol	Dimensions In Millimeters	
	MIN.	MAX.
E3	8.50	
H1	6.55	6.75
L1	0.50	0.90
L4	0.13	0.33
θ	10°REF	
ccc	0.20	
ddd	0.25	

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